

PRINCIPLES  
OF ELECTRON  
OPTICS

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*V o l u m e 3*

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*WAVE*

*OPTICS*

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# Contents of Volume 3

## Wave Optics

### Preface

Chapter	54	Introduction	1191
	54.1	Organization of the subject	1191
	54.2	History	1195

### PART XI – WAVE MECHANICS

Chapter	55	The Schrödinger Equation	1211
	55.1	Introduction	1211
	55.2	Formulation of Schrödinger's equation	1211
	55.3	The continuity equation	1213
	55.4	The gauge transformation	1215
Chapter	56	The Relativistic Wave Equation	1217
	56.1	The Dirac equation	1217
	56.2	The scalar wave equation	1218
	56.3	Properties of the relativistic wave equation	1220
	56.4	Rigorous approach	1223
Chapter	57	The Eikonal Approximation	1224
	57.1	The product separation	1224
	57.2	The essential approximation	1225
	57.3	The variational principle	1228
	57.4	The calculation of eikonal functions	1231
	57.5	The calculation of wave amplitudes	1232
Chapter	58	Paraxial Wave Optics	1235
	58.1	The paraxial Schrödinger equation	1235
	58.2	Particular solution of the paraxial Schrödinger equation	1241
	58.3	Paraxial image formation	1244
Chapter	59	The General Theory of Electron Diffraction and Interference	1251
	59.1	Kirchhoff's general diffraction formula	1251
	59.2	Necessary simplifications	1253
	59.3	Fresnel and Fraunhofer diffraction	1255

59.4	Electron diffraction in the presence of electromagnetic fields	1257	
59.5	Asymptotic diffraction formulae	1263	
59.6	The observability of diffraction and interference fringes	1267	
<b>Chapter</b>	<b>60</b>	<b>Elementary Diffraction Patterns</b>	<b>1273</b>
60.1	The object function	1273	
60.2	Rectangular structures	1276	
60.3	Circular structures	1281	
60.4	Caustic interferences	1287	
60.5	Diffraction disc with lens aberrations	1291	
60.6	The Rayleigh rule and criterion	1295	

## PART XII – ELECTRON INTERFERENCE AND ELECTRON HOLOGRAPHY

<b>Chapter</b>	<b>61</b>	<b>General Introduction</b>	<b>1301</b>
<b>Chapter</b>	<b>62</b>	<b>Principles of Interferometry</b>	<b>1311</b>
62.1	The electrostatic biprism	1311	
62.2	Quasi-homogeneous interference fringes	1318	
62.3	Coherence problems	1324	
62.4	The Aharonov-Bohm effect	1330	
62.5	Other electron interference studies	1332	
<b>Chapter</b>	<b>63</b>	<b>Principles of Holography</b>	<b>1336</b>
63.1	In-line holography	1337	
63.2	Off-axis holography: hologram formation in a two-beam interferometer	1344	
63.3	Reconstruction procedures	1352	
63.4	Further reading	1361	

## PART XIII – THEORY OF IMAGE FORMATION

<b>Chapter</b>	<b>64</b>	<b>General Introduction</b>	<b>1365</b>
<b>Chapter</b>	<b>65</b>	<b>Fundamentals of Transfer Theory</b>	<b>1370</b>
65.1	The integral transformation	1370	
65.2	Isoplanatism and Fourier transforms	1373	
65.3	The wave transfer function	1376	
65.4	Explicit formulae	1380	
<b>Chapter</b>	<b>66</b>	<b>The Theory of Bright-field Imaging</b>	<b>1385</b>
66.1	Image contrast for weak specimens	1385	

66.2	Spectral distributions of the illumination	1397
66.3	Particular forms of the spectra	1410
66.4	Optimum defocus and resolution limit	1415
66.5	Extensions of the theory	1421
Chapter 67	Image Formation in the Scanning Transmission Electron Microscope	1441
67.1	Introduction	1441
67.2	Wave propagation in STEM	1441
67.3	Detector geometry	1446
67.4	Concluding remarks	1453

## PART XIV – ELECTRON INTERACTIONS IN THIN SPECIMENS

Chapter 68	Electron Interactions in Amorphous Specimens	1457
68.1	Introduction	1457
68.2	Definition of the elastic cross-sections	1459
68.3	The first-order Born approximation for elastic scattering	1461
68.4	The high-energy approximation	1468
68.5	Partial wave analysis	1472
68.6	Inelastic electron scattering	1475
68.7	Plural and multiple electron scattering	1481
Chapter 69	Electron Interactions in Crystalline Specimens	1488
69.1	Introduction	1488
69.2	Fundamentals of crystallography	1490
69.3	The periodic potential	1494
69.4	Kinematic theory of electron scattering	1497
69.5	General formulation of the dynamical theory	1505
69.6	The two-beam case	1513
69.7	Applications and extensions of the dynamical theory	1522
69.8	Image simulation	1527

## PART XV – DIGITAL IMAGE PROCESSING

Chapter 70	Introduction	1531
70.1	Organization of the subject	1531
70.2	Image algebra	1534
70.3	Notation	1542

Chapter	71	Acquisition, Sampling and Coding	1545
	71.1	Acquisition	1545
	71.2	Sampling	1546
	71.3	Quantization	1554
	71.4	Coding	1556
	71.5	Electron optical considerations	1560
Chapter	72	Enhancement	1562
	72.1	Operations on individual pixels	1562
	72.2	Linear filtering	1566
	72.3	Nonlinear filters	1574
	72.4	Image algebraic representation of enhancement	1593
	72.5	Enhancement in electron microscopy	1594
Chapter	73	Linear Restoration	1595
	73.1	Introduction	1595
	73.2	Extended Wiener filters	1596
	73.3	Filtering with constraints	1603
	73.4	Hoenders' procedure	1607
	73.5	Recursive filtering	1609
	73.6	Other approaches	1612
Chapter	74	Nonlinear Restoration	1613
	74.1	Introduction	1613
	74.2	Extended linear approximation	1614
	74.3	Multiple recordings (circular symmetry)	1618
	74.4	Analyticity	1630
	74.5	Maximum entropy and related probabilistic methods	1650
Chapter	75	Three-dimensional Reconstruction	1653
	75.1	Introduction	1653
	75.2	Methods	1660
	75.3	Pre-processing	1670
	75.4	Concluding remarks	1681
Chapter	76	Image Analysis	1683
	76.1	Introduction	1683
	76.2	Discrete geometry	1684
	76.3	Segmentation and feature extraction	1686
	76.4	Classification	1697
	76.5	Description	1699
	76.6	Further reading	1703
Chapter	77	Instrument Control and Instrumental Image Manipulation	1705



77.1	Introduction	1705
77.2	Measurement of microscope operating parameters	1706
77.3	Control	1710

## PART XVI – COHERENCE, BRIGHTNESS AND SPECTRAL FUNCTIONS

Chapter	78	Coherence and the Brightness Functions	1719
	78.1	Introduction	1719
	78.2	Coherence	1720
	78.3	Radiometry	1730
	78.4	The brightness of partially coherent sources	1731
	78.5	Consequences for the van Cittert-Zernike theorem	1735
	78.6	Eigenfunction expansions of the coherence functions	1736
	78.7	The quasihomogeneous source	1743
	78.8	Brightness, coherence and quasihomogeneity	1748
	78.9	Temporal and spatial coherence	1752
	78.10	Related work	1757
Chapter	79	Instrumental Aspects of Coherence	1761
	79.1	Introduction	1761
	79.2	The propagation of coherence functions	1761
	79.3	Coherence and illumination	1767
Appendix			1769
Notes and References			1773
Index			